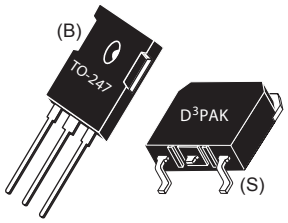
Microsemi
POWER PRODUCTS GROUP

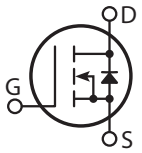
600V 60A 0.045Ω
APT60N60BCSG*
APT60N60SCSG*
***G Denotes RoHS Compliant, Pb Free Terminal Finish.**

COOLMOS
Power Semiconductors

Super Junction MOSFET



- **Ultra Low $R_{DS(ON)}$**
- **Low Miller Capacitance**
- **Ultra Low Gate Charge, Q_g**
- **Avalanche Energy Rated**
- **Extreme dv/dt Rated**
- **Popular TO-247 or Surface Mount D^3 Package**



MAXIMUM RATINGS

All Ratings: T_C = 25°C unless otherwise specified.

Symbol	Parameter	APT60N60BCSG_SCSG	UNIT
V_{DSS}	Drain-Source Voltage	600	Volts
I_D	Continuous Drain Current @ T_C = 25°C	60	Amps
	Continuous Drain Current @ T_C = 100°C	38	
I_{DM}	Pulsed Drain Current ①	230	
V_{GS}	Gate-Source Voltage Continuous	±30	Volts
P_D	Total Power Dissipation @ T_C = 25°C	431	Watts
	Linear Derating Factor	3.45	W/°C
T_J,T_{STG}	Operating and Storage Junction Temperature Range	-55 to 150	°C
T_L	Lead Temperature: 0.063" from Case for 10 Sec.	260	
dv/dt	MOSFET dv/dt Ruggedness (V_{DS} = 480V)	50	V/ns
I_{AR}	Avalanche Current ②	11	Amps
E_{AR}	Repetitive Avalanche Energy ②	3	mJ
E_{AS}	Single Pulse Avalanche Energy ③	1950	

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage (V_{GS} = 0V, I_D = 250µA)	600			Volts
$R_{DS(on)}$	Drain-Source On-State Resistance ④ (V_{GS} = 10V, I_D = 44A)			0.045	Ohms
I_{DSS}	Zero Gate Voltage Drain Current (V_{DS} = 600V, V_{GS} = 0V)			25	µA
	Zero Gate Voltage Drain Current (V_{DS} = 600V, V_{GS} = 0V, T_C = 150°C)			250	
I_{GSS}	Gate-Source Leakage Current (V_{GS} = ±20V, V_{DS} = 0V)			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage (V_{DS} = V_{GS}, I_D = 3mA)	2.1	3	3.9	Volts

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

"COOLMOS™ comprise a new family of transistors developed by Infineon Technologies AG. "COOLMOS" is a trade-mark of Infineon Technologies AG."

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DYNAMIC CHARACTERISTICS

APT60N60BCSG_SCSG

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C_{iss}	Input Capacitance	V_{GS} = 0V V_{DS} = 25V f = 1 MHz		7200		pF
C_{oss}	Output Capacitance			8500		
C_{rss}	Reverse Transfer Capacitance			290		
Q_g	Total Gate Charge ⑤	V_{GS} = 10V V_{DD} = 400V I_D = 44A @ 25°C		150	190	nC
Q_{gs}	Gate-Source Charge			34		
Q_{gd}	Gate-Drain ("Miller") Charge			50		
$t_{d(on)}$	Turn-on Delay Time	**RESISTIVE SWITCHING** V_{GS} = 15V V_{DD} = 400V I_D = 44A @ 25°C R_G = 4.3Ω		30		ns
t_r	Rise Time			20		
$t_{d(off)}$	Turn-off Delay Time			100		
t_f	Fall Time			10		
E_{on}	Turn-on Switching Energy ⑥	**INDUCTIVE SWITCHING @ 25°C** V_{DD} = 400V, V_{GS} = 15V I_D = 44A, R_G = 4.3Ω		675		µJ
E_{off}	Turn-off Switching Energy			520		
E_{on}	Turn-on Switching Energy ⑥	**INDUCTIVE SWITCHING @ 125°C** V_{DD} = 400V, V_{GS} = 15V I_D = 44A, R_G = 4.3Ω		1100		
E_{off}	Turn-off Switching Energy			635		

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
I_S	Continuous Source Current (Body Diode)			44	Amps
I_{SM}	Pulsed Source Current ① (Body Diode)			180	
V_{SD}	Diode Forward Voltage ④ (V_{GS} = 0V, I_S = -44A)			1.2	Volts
t_{rr}	Reverse Recovery Time (I_S = -44A, dI_S/dt = 100A/µs)		600		ns
Q_{rr}	Reverse Recovery Charge (I_S = -44A, dI_S/dt = 100A/µs)		17		µC
$^{dv}/_{dt}$	Peak Diode Recovery $^{dv}/_{dt}$ ⑦			4	V/ns

THERMAL CHARACTERISTICS

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction to Case			0.29	°C/W
$R_{\theta JA}$	Junction to Ambient			40	

① Repetitive Rating: Pulse width limited by maximum junction temperature

② Repetitive avalanche causes additional power losses that can be calculated as $P_{AV} = E_{AR}*f$

③ Starting T_j = +25°C, L = 33.23mH, R_G = 25Ω, Peak I_L = 11A

④ Pulse Test: Pulse width < 380µs, Duty Cycle < 2%

⑤ See MIL-STD-750 Method 3471

⑥ Eon includes diode reverse recovery. See figures 18, 20.

⑦ We do not recommend using this CoolMOS™ product in topologies that have fee wheeling load current conducted in the body diode that is hard commutated. The current commutation is very "snappy", resulting in high di/dt at the completion of commutation, and the likelihood of severe over-voltage transients due to the resulting high dv/dt.

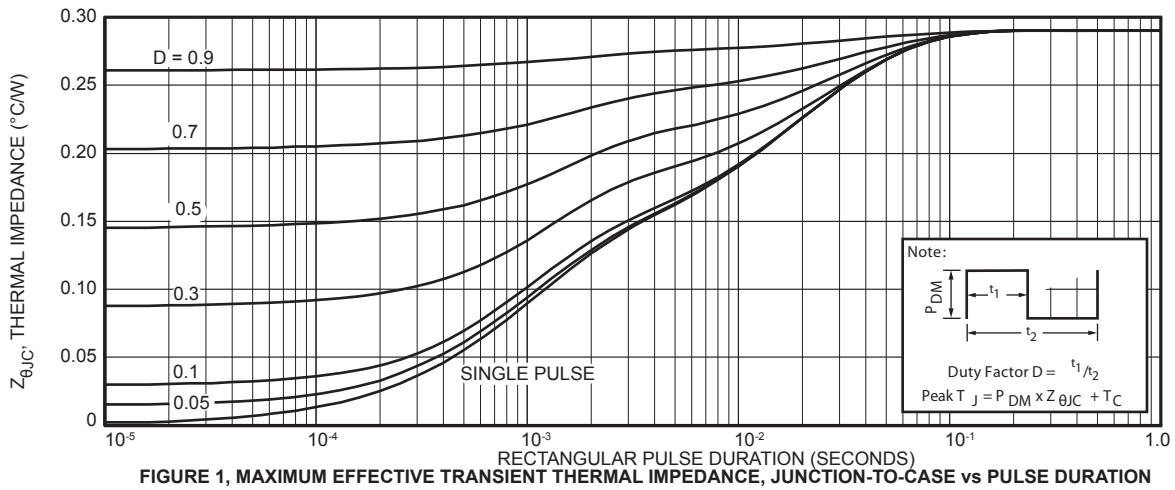


FIGURE 1, MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs PULSE DURATION

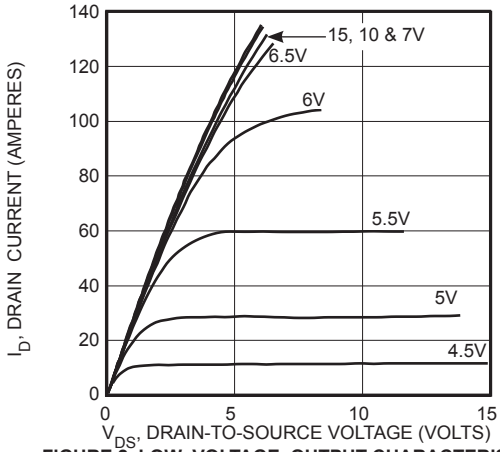


FIGURE 2, LOW VOLTAGE OUTPUT CHARACTERISTICS

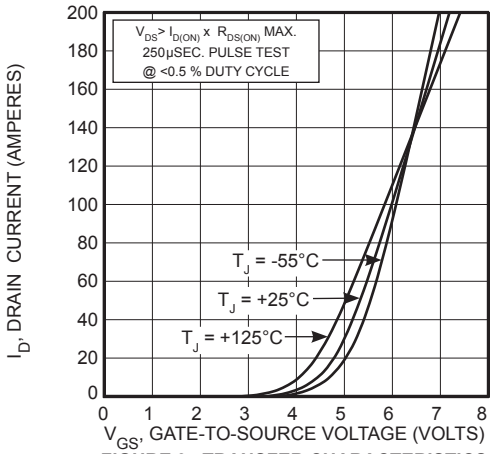


FIGURE 3, TRANSFER CHARACTERISTICS

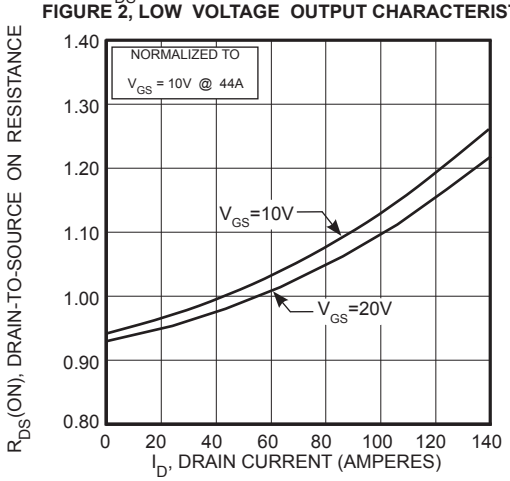


FIGURE 4, R_{DS}(ON) vs DRAIN CURRENT

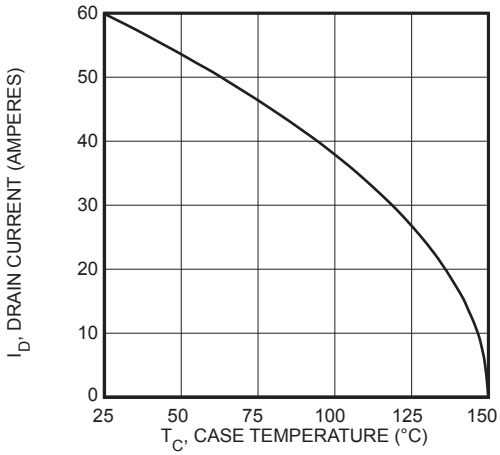


FIGURE 5, MAXIMUM DRAIN CURRENT vs CASE TEMPERATURE

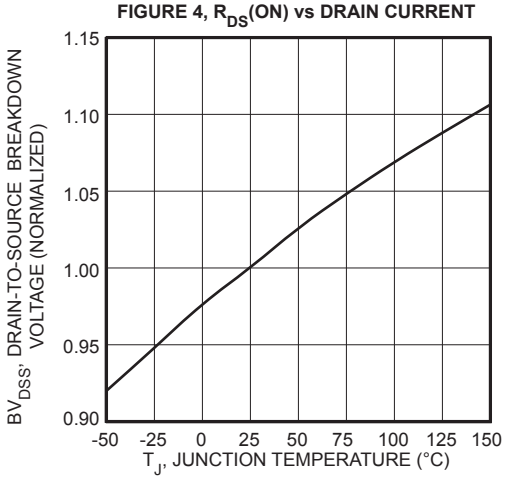


FIGURE 6, BREAKDOWN VOLTAGE vs TEMPERATURE

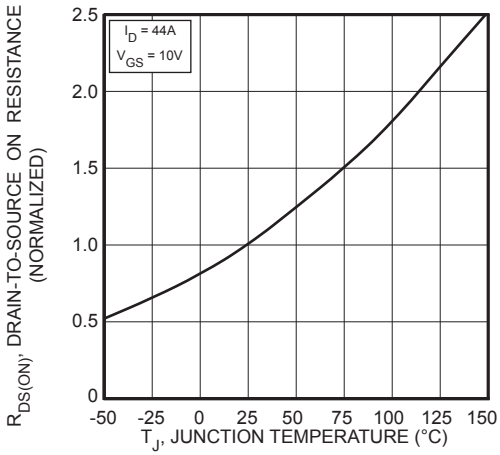


FIGURE 7, ON-RESISTANCE vs. TEMPERATURE

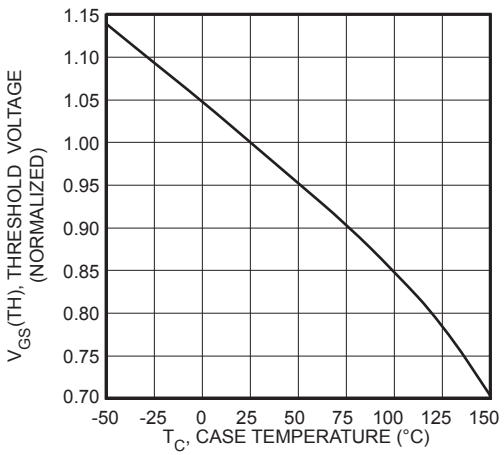


FIGURE 8, THRESHOLD VOLTAGE vs TEMPERATURE

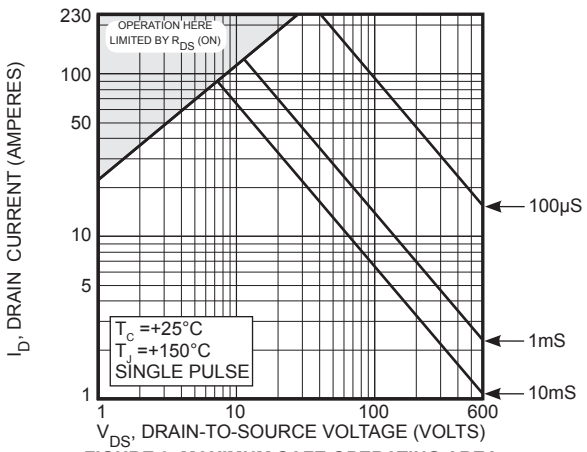


FIGURE 9, MAXIMUM SAFE OPERATING AREA

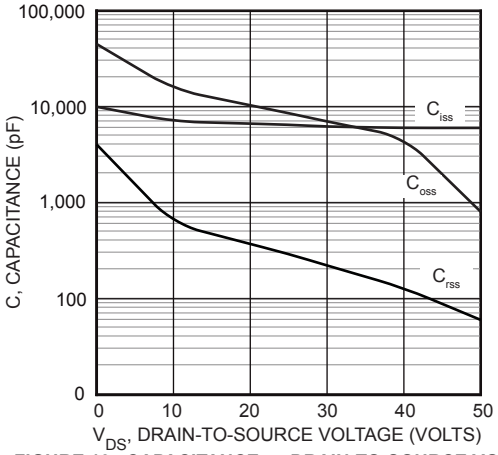


FIGURE 10, CAPACITANCE vs DRAIN-TO-SOURCE VOLTAGE

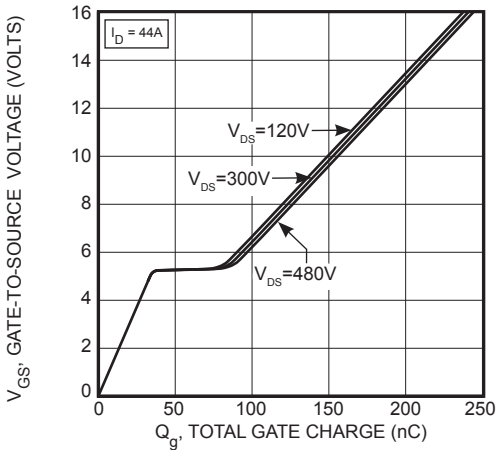


FIGURE 11, GATE CHARGE vs GATE-TO-SOURCE VOLTAGE

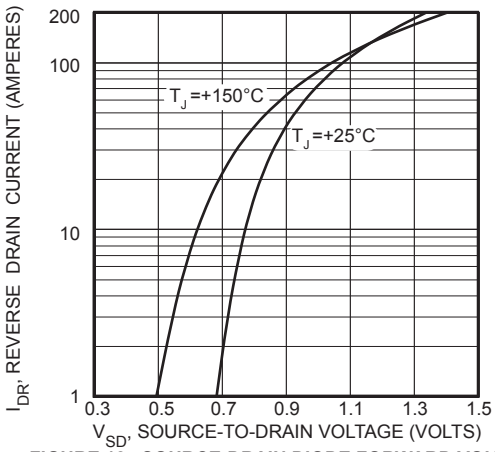


FIGURE 12, SOURCE-DRAIN DIODE FORWARD VOLTAGE

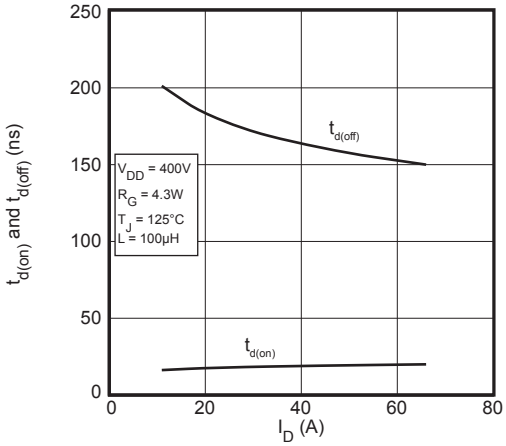


FIGURE 13, DELAY TIMES vs CURRENT

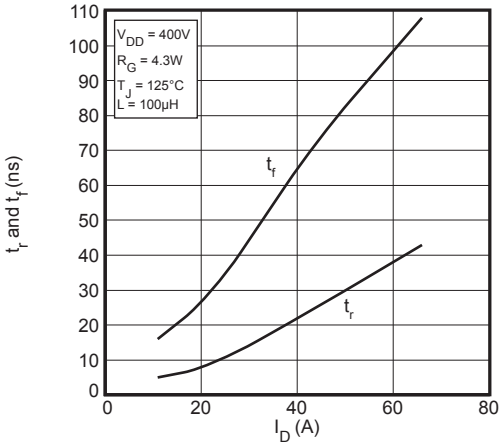


FIGURE 14, RISE AND FALL TIMES vs CURRENT

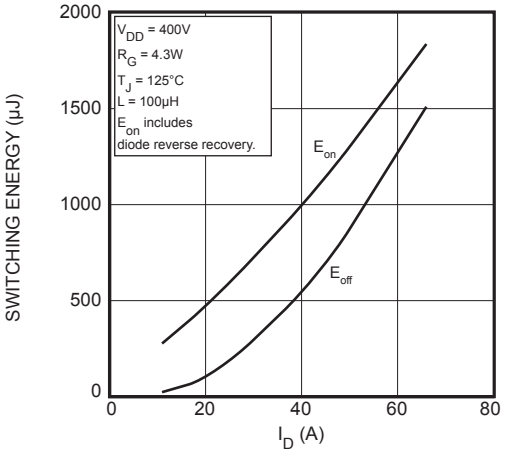


FIGURE 15, SWITCHING ENERGY vs CURRENT

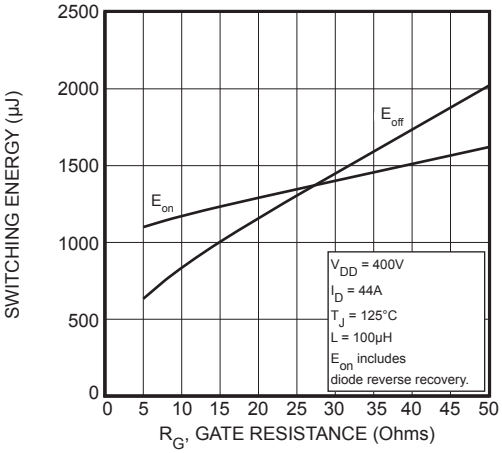


FIGURE 16, SWITCHING ENERGY vs GATE RESISTANCE

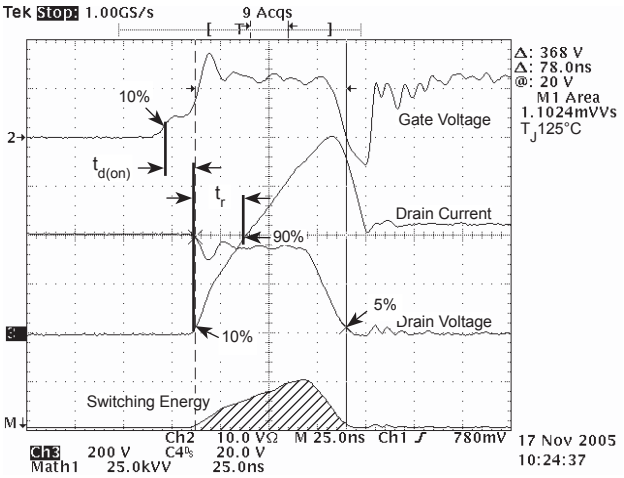


Figure 17, Turn-on Switching Waveforms and Definitions

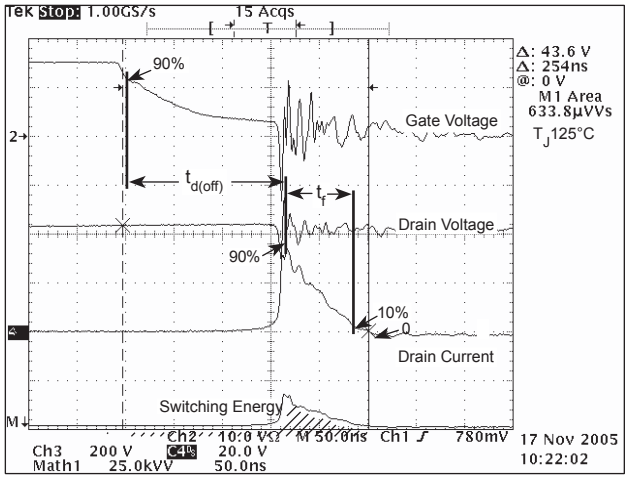


Figure 18, Turn-off Switching Waveforms and Definitions

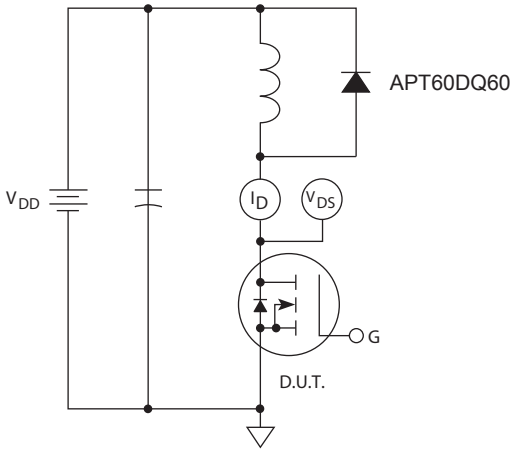
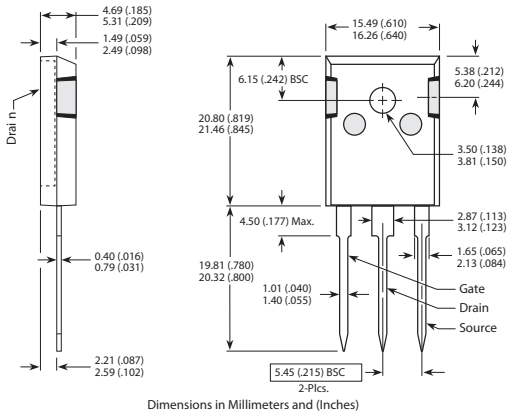


Figure 19, Inductive Switching Test Circuit

TO-247 Package Outline

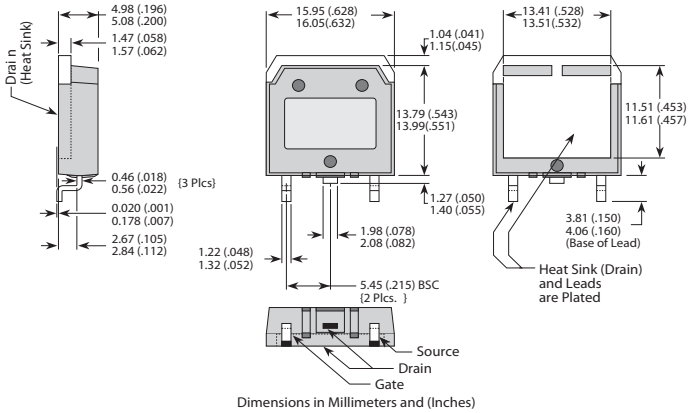
e3 100% Sn



Dimensions in Millimeters and (Inches)

D³PAK Package Outline

e3 100% Sn



Dimensions in Millimeters and (Inches)